

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/620,093	BERTHOLD ET AL.	
Examiner	Art Unit	
Phallaka Kik	2825	

SEARCHED					
Class	Subclass	Date	Examiner		
716	6,13,14	10/17/2005	PK		
703	16	10/17/2005	PK		
702	79,125	10/17/2005	PK		
702	181	10/17/2005	PK		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
BRS (EAST)USPAT, USPGPUB Class/Sub Searched: 716/1-18; 703/14-16; 702/79,117,125,181 (see attached)	10/17/2005	PK		
EPO, JPO, IBM TDB, Derwent (see attached)	10/17/2005	PK		
IEE/IEEE Xplore (see attached)	10/17/2005	PK		